SERIAL NO. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY DOCKET NO. Form PTO 1449 (Modified) 09/504,965 5244-0107-2 APPLICANT LIST OF REFERENCES PEDIBORATE Xiaoan HOU, et al. GROUP **FILING DATE** FEB 0 3 2005 % 2622 February 16, 2000 **FOREIGN PATENT DOCUMENTS TRANSLATION** DOCUMENT DATE COUNTRY NUMBER YES NO 0 241 273 10/14/87 **EUROPE** XX AA XX AB 0 354 703 02/14/90 **EUROPE** AC 59-064956 04/13/84 JAPAN W/ENGLISH ABSTRACT XX XX **GERMAN W/ENGLISH ABSTRACT** DE 350 7479 09/04/86 AD EUROPE 10/23/85 XX ΑE 0 159 158 JAPAN W/ENGLISH ABSTRACT XX ΑF 60-167568 08/30/85 XX 60-173968 09/07/85 JAPAN W/ENGLISH ABSTRACT AG 09/18/85 JAPAN W/ENGLISH ABSTRACT XX AH 60-182851 XX 11/01/85 JAPAN W/ENGLISH ABSTRACT 60-218961 10/02/85 JAPAN WÆNGLISH ABSTRACT XX ΑJ 60-194472 07/18/87 JAPAN W/ENGLISH ABSTRACT XX 62-162551 AK P 08/16/83 JAPAN WÆNGLISH ABSTRACT XX AL 58-138162 19 AM 59-099846 06/08/84 **ENGLISH ABSTRACT** $\Im P \times$ XX JAPAN W/ENGLISH ABSTRACT XX AN 58-138148 08/16/83 XX 09/30/83 JAPAN W/ENGLISH ABSTRACT AO 58-165452 07/26/82 **ENGLISH ABSTRACT** XX ΔP 57-119541 11/26/82 JAPAN W/ENGLISH ABSTRACT XX 57-192167 AQ AR 57-119537 07/26/82 **ENGLISH ABSTRACT** XX 03/30/89 JAPAN WÆNGLISH ABSTRACT XX 3 AS 64-086180 J 05/31/89 JAPAN W/ENGLISH ABSTRACT XX ΑT 1-138524 JP AU 2-060763 03/01/90 JAPAN W/ENGLISH ABSTRACT XX 12/12/84 JAPAN W/ENGLISH ABSTRACT XX 59-221165 AV 07/06/84 JAPAN W/ENGLISH ABSTRACT XX AW 59-117372 JAPAN W/ENGLISH ABSTRACT XX 59-117845 07/07/84 JP JAPAN W/ENGLISH ABSTRACT XX 11/07/88 63-269664 AY XX ΑZ 63-269665 11/07/88 JAPAN WÆNGLISH ABSTRACT J 01/26/89 JAPAN WÆNGLISH ABSTRACT XX 64-024561 AAA JAPAN W/ENGLISH ABSTRACT XX AAB 64-050671 02*/*27/89 JAPAN W/ENGLISH ABSTRACT XX 11/07/88 AAC 63-269663 06/15/87 JAPAN W/ENGLISH ABSTRACT XX AAD 62-132464 JAPAN W/ENGLISH ABSTRACT XX 10/14/83 AAE 58-175342 01/30/88 **ENGLISH ABSTRACT W/DRAWING** XX AAF 63-023469 JAPAN W/ENGLISH ABSTRACT AAG 64-012657 01/17/89 XX 07/19/89 JAPAN W/ENGLISH ABSTRACT XX AAH 1-181373 4/22/05 Date Considered Ехатілег Examiner: Initial #/eference is considered, whether or not/citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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